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(54) **MEASURING APPARATUS AND
MEASURING DEVICE FOR MEASURING A
TARGET OBJECT IN A
MULTIDIMENSIONAL MANNER**

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(58) **Field of Classification Search**

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See application file for complete search history.

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(57) **ABSTRACT**

The disclosure relates to a measuring apparatus, in particular
a handheld measuring apparatus, for measuring a target
object in a multidimensional manner, wherein the distance to
individual object points of the target object is sequentially
measured, in particular using a phase-measuring system,
which apparatus has at least: a transmitting device for
emitting optical measuring radiation towards the target
object; a receiving device having a detection area for detect-
ing optical measuring radiation returning from the target
object; a scanning system for deflecting the optical measur-
ing radiation, and an evaluation device for determining
measured distance values. The detection area of the receiv-
ing device has a plurality of pixels, wherein each pixel has
at least one SPAD, and wherein each of the plurality of

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